P-Channel PowerTrench® **MOSFET**

-20 V, -75 A, 4.9 m Ω

General Description

This P-Channel MOSFET is produced using ON Semiconductor's advanced PowerTrench® process that has been optimized for r_{DS(on)}, switching performance and ruggedness.

Features

- Max $r_{DS(on)} = 4.9 \text{ m}\Omega$ at $V_{GS} = -4.5 \text{ V}$, $I_D = -18 \text{ A}$
- Max $r_{DS(on)} = 16.4 \text{ m}\Omega$ at $V_{GS} = -1.8 \text{ V}$, $I_D = -9 \text{ A}$
- High Performance Trench Technology for Extremely Low r_{DS(on)}
- High Power and Current Handling Capability in a Widely Used Surface Mount Package
- These Devices are Pb-Free, Halogen Free/BFR Free and are RoHS Compliant

Applications

- Load Switch
- Battery Management
- Power Management
- Reverse Polarity Protection

MAXIMUM RATINGS (T_A = 25°C unless otherwise noted)

Symbol	Parameter	Value	Unit
V _{DS}	Drain to Source Voltage	-20	V
V _{GS}	Gate to Source Voltage	±12	V
I _D		-75 -47 -18 -335	Α
E _{AS}	Single Pulse Avalanche Energy (Note 3)	54	mJ
P _D	Power Dissipation: T _C = 25°C T _A = 25°C (Note 1a)	40 2.4	W
T _J , T _{STG}	Operating and Storage Junction Temperature Range	–55 to +150	°C

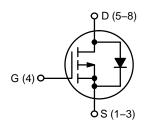
Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.



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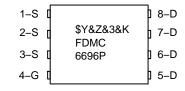
V _{DS}	R _{DS(ON)} MAX	I _D MAX
	4.9 mΩ @ -4.5 V	
–20 V	6.5 mΩ @ -2.5 V	–75 A
	16.4 mΩ @ –1.8 V	



P-Channel MOSFET



MARKING DIAGRAM



\$Y = ON Semiconductor Logo &Z = Assembly Plant Code &3 = Data Code (Year & Week) &K FDMC6696P = Specific Device Code

ORDERING INFORMATION

See detailed ordering and shipping information on page 3 of this data sheet

THERMAL CHARACTERISTICS

Symbol	Parameter	FDMC6696P	Unit
$R_{ heta JC}$	Thermal Resistance, Junction to Case	3.1	°C/W
$R_{ heta JA}$	Thermal Resistance, Junction to Ambient (Note 1a)	53	

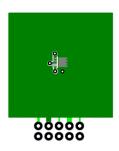
ELECTRICAL CHARACTERISTICS (T_{.1} = 25°C unless otherwise noted)

Symbol	Parameter	Test Conditions	Min.	Тур.	Max.	Units
OFF CHARACT	ERISTICS					
BV _{DSS}	Drain to Source Breakdown Voltage	$I_D = -250 \mu\text{A}, V_{GS} = 0 \text{V}$	-20			V
$\Delta BV_{DSS}/\Delta T_{J}$	Breakdown Voltage Temperature Coefficient	I_D = -250 μ A, Referenced to 25 $^{\circ}$ C		-15		mV/°C
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} = - 16 V, V _{GS} = 0 V			-1	μΑ
I _{GSS}	Gate to Source Leakage Current	$V_{GS} = \pm 12 \text{ V}, V_{DS} = 0 \text{ V}$			±100	nA
ON CHARACTE	RISTICS					
V _{GS(th)}	Gate to Source Threshold Voltage	$V_{GS} = V_{DS}, I_{D} = -250 \mu A$	-0.4	-0.7	-1.6	V
$\Delta V_{GS(th)} \ \Delta T_J$	Gate to Source Threshold Voltage Temperature Coefficient	I_D = -250 μ A, referenced to 25 °C		4		mV/°C
r _{DS(on)}	Static Drain to Source On Resistance	$V_{GS} = -4.5 \text{ V}, I_D = -18 \text{ A}$		3.3	4.9	mΩ
		V _{GS} = -2.5 V, I _D = -11 A		4.1	6.5	
		$V_{GS} = -1.8 \text{ V}, I_D = -9 \text{ A}$		6.2	16.4	
		$V_{GS} = -4.5 \text{ V}, I_{D} = -18 \text{ A},$ $T_{J} = 125 ^{\circ}\text{C}$		4.5	6.8	-
9FS	Forward Transconductance	$V_{DS} = -5 \text{ V}, I_{D} = -18 \text{ A}$		113		S
DYNAMIC CHA	RACTERISTICS		•	•		
C _{iss}	Input Capacitance	$V_{DS} = -10 \text{ V}, V_{GS} = 0 \text{ V},$		7535	10550	pF
C _{oss}	Output Capacitance	f = 1 MHz		1100	1540	pF
C _{rss}	Reverse Transfer Capacitance			1040	1455	pF
R _g	Gate Resistance		0.1	4.5	10	Ω
SWITCHING CH	IARACTERISTICS					·
t _{d(on)}	Turn-On Delay Time	$V_{DD} = -10 \text{ V}, I_D = -18 \text{ A},$		13	23	ns
t _r	Rise Time	$V_{GS} = -4.5 \text{ V}, R_G = 6 \Omega$		17	31	ns
t _{d(off)}	Turn-Off Delay Time			312	499	ns
t _f	Fall Time			176	282	ns
Qg	Total Gate Charge	$V_{GS} = 0 \text{ V to } -4.5 \text{ V}, V_{DD} = -10 \text{ V},$ $I_D = -18 \text{ A}$		78	109	nC
		$V_{GS} = 0 \text{ V to } -2.5 \text{ V}, V_{DD} = -10 \text{ V}, I_{D} = -18 \text{ A}$		50	70	nC
Q _{gs}	Gate to Source Charge	$V_{DD} = -10 \text{ V}, I_D = -18 \text{ A}$		12		nC
Q _{gd}	Gate to Drain "Miller" Charge	$V_{DD} = -10 \text{ V}, I_D = -18 \text{ A}$		24		nC
DRAIN-SOURC	E DIODE CHARACTERISTICS					
V_{SD}	Source to Drain Diode Forward Voltage	$V_{GS} = 0 \text{ V}, I_{S} = -18 \text{ A (Note 2)}$		-0.7	-1.2	V
		V _{GS} = 0 V, I _S = -2 A (Note 2)		-0.6	-1.2	
t _{rr}	Reverse Recovery Time	$I_S = -18 \text{ A}, \text{ di/dt} = 100 \text{ A/}\mu\text{s}$		41	66	ns
Q _{rr}	Reverse Recovery Charge	1		22	35	nC

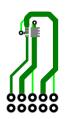
Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions.

1. $R_{\theta JA}$ is determined with the device mounted on a 1 in² pad 2 oz copper pad on a 1.5 x 1.5 in. board of FR-4 material. $R_{\theta CA}$ is determined by the user's board design.

NOTES:



a) 53 $^{\circ}\text{C/W}$ when mounted on a 1 in² pad of 2 oz copper.



b) 125 $^{\circ}\text{C/W}$ when mounted on a minimum pad of 2 oz copper.

- Pulse Test: Pulse Width < 300 μs, Duty cycle < 2.0 %
 E_{AS} of 54 mJ is based on starting T_J = 25 C, L = 3 mH, I_{AS} = -6 A, V_{DD} = -20 V, V_{GS} = -10 V.
 Pulsed Id please refer to Fig 11 SOA graph for more details.
 Compute documental continuous current will be limited by thermal & electro-mechanical application board design.

PACKAGE MARKING AND ORDERING INFORMATION

Device Marking	Device	Package	Reel Size	Tape Width	Quantity
FDMC6696P	FDMC6696P	PQFN8 (Pb Free)	13"	12 mm	3000 Units

TYPICAL CHARACTERISTICS

(T_J = 25 °C unless otherwise noted)

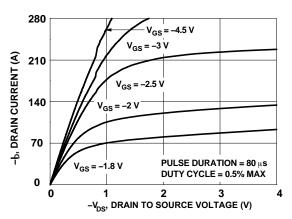


Figure 1. On-Region Characteristics

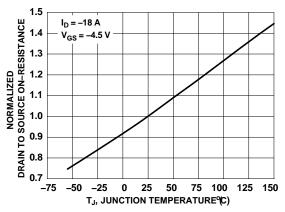


Figure 3. Normalized On–Resistance vs Junction Temperature

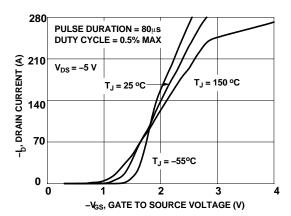


Figure 5. Transfer Characteristics

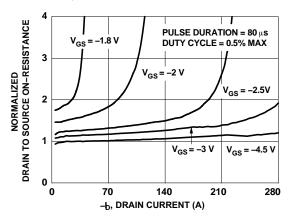


Figure 2. Normalized On–Resistance vs. Drain Currentand Gate Voltage

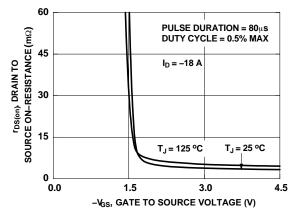


Figure 4. On–Resistance vs Gate to Source Voltage

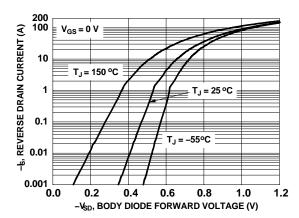


Figure 6. Source to Drain Diode Forward Voltage vs Source Current

TYPICAL CHARACTERISTICS

(T_J = 25 °C unless otherwise noted)

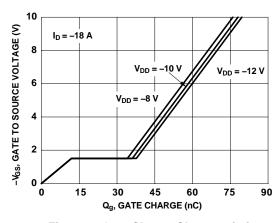


Figure 7. Gate Charge Characteristics

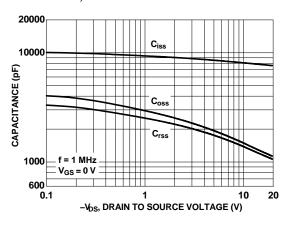


Figure 8. Capacitance vs Drain to Source Voltage

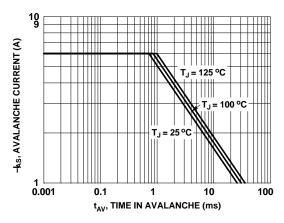


Figure 9. Unclamped Inductive Switching Capability

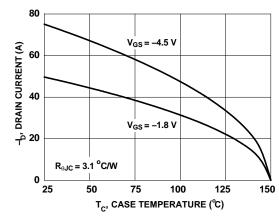


Figure 10. Maximum Continuous Drain Current vs Case Temperature

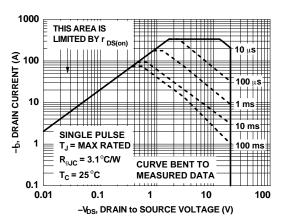


Figure 11. Forward Bias Safe Operating Area

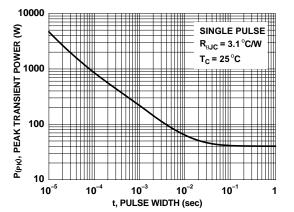


Figure 12. Single Pulse Maximum Power Dissipation

TYPICAL CHARACTERISTICS

(T_J = 25 °C unless otherwise noted)

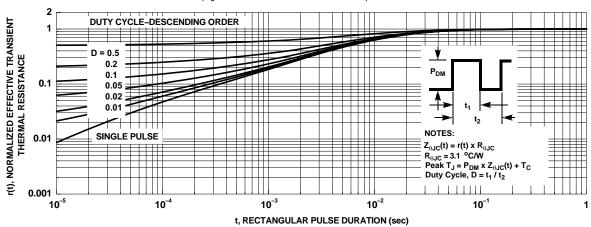
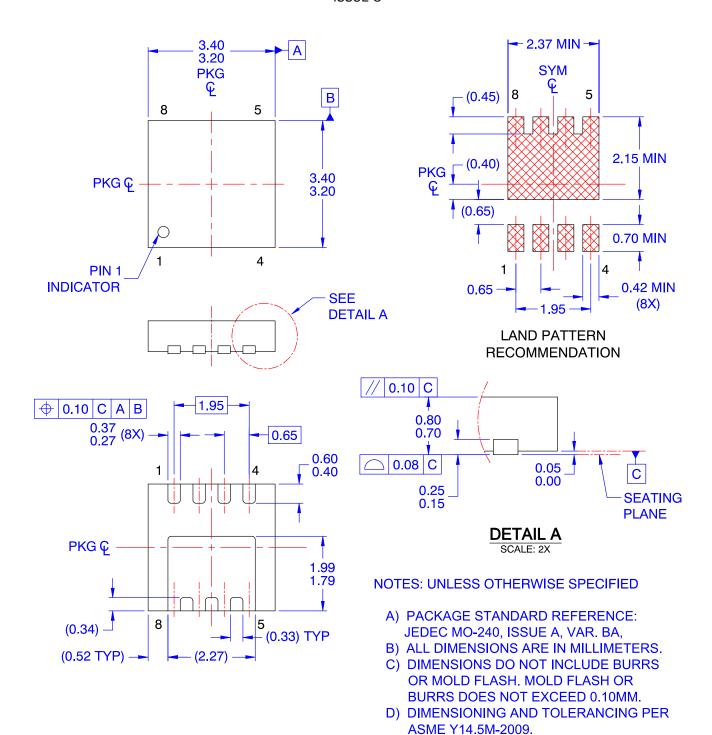


Figure 13. Junction-to-Case Transient Thermal Response Curve

PQFN8 3.3X3.3, 0.65P CASE 483AX ISSUE O



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